


<b>Search Notes</b> 	<b>Application/Control No.</b> 10676889	<b>Applicant(s)/Patent Under Reexamination</b> LIAO ET AL.
	<b>Examiner</b> Mitchell, Jason	<b>Art Unit</b> 2193

SEARCHED			
Class	Subclass	Date	Examiner
717	106,149-150,151-158	10/25/07	/jm/
708	233	10/25/07	/jm/
712	205-207,219	10/25/07	/jm/
717	106,149-158	8/19/08	/jm/
708	233	8/19/08	/jm/
712/jm/	25-207,219	8/19/08	/jm/

SEARCH NOTES		
Search Notes	Date	Examiner
eDan inventor search	10/25/07	/jm/
east search	10/25/07	/jm/
google search	10/25/07	/jm/
east search	8/19/08	/jm/
east search w/ ltd. class search (see notes)	2/16/09	/jm/
east search w/ ltd. class search (717/106,149-150,151-158 712/205-207,219,225,235)	7/22/09	/jm/
east search w/ ltd class search 717/106,149-158 708/233 712/204-207	12/31/09	/jm/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner.Art Unit 2193

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Primary Examiner.Art Unit 2193